



Questions, Thoughts, or Comments?

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M4 TORNADO^{PLUS} – A New Era in Micro-XRF



Bruker Nano Analytics, Berlin, Germany Webinar, September 19th 2019



Introduction Presenters / Moderators





Falk Reinhardt

Application Scientist, Bruker Nano Analytics, Berlin, Germany



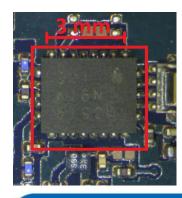
Dr. Max J.L. Bügler Applications Specialist,

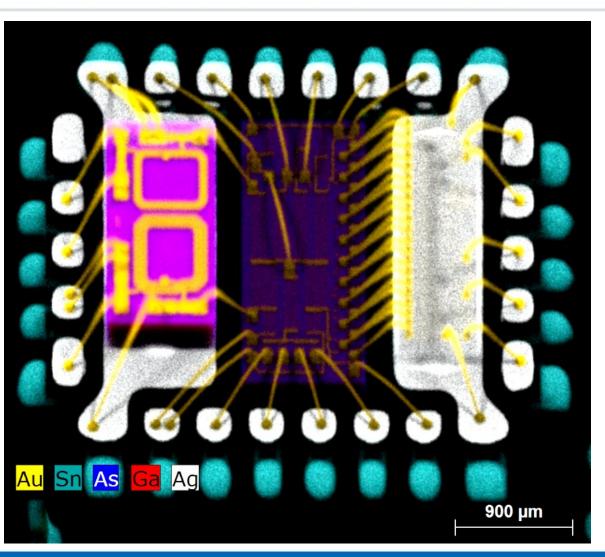
Bruker Nano Analytics, Berlin, Germany

Introduction The method – micro-XRF



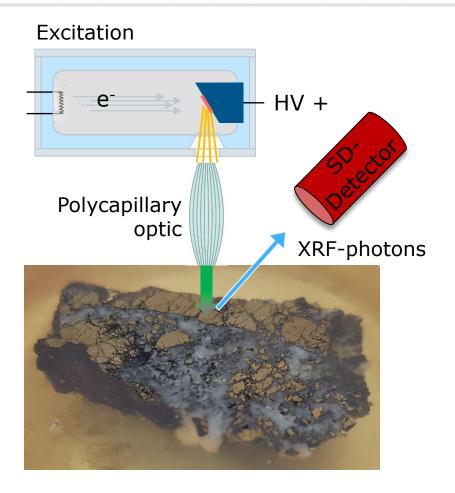
- Little to no sample preparation
- Non-destructive
- Elemental information
- Small spot analysis
- Information from within the sample
- Large-scale
- Quantification

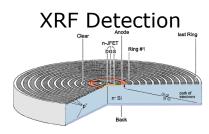




Introduction ...in other words







Silicon Drift Detector with XFlash® Technology

- X-rays can be guided onto a small spot
- Spatially resolved elementspecific signal
- Intensity ratios of observed elemental lines can be used for quantification

6

The instrument M4 Tornado

30 W micro-focus Rh tube with polycapillary lens

for excitation spot sizes < 20 μ m (for Mo-Ka)

Optional 40 W micro-focus W tube with collimator

for excitation of 'heavy' elements, embedded in lighter matrices (not used here)

Up to two Silicon drift detectors (SDD)

with 30 or 60 mm² active area each energy resolution < 145 eV optional with light element window (for Mn-Ka @ 130 kcps throughput)

Sealed sample chamber with adjustable pressure

between 1 mbar and atmospheric pressure for detecting elements down to Na (down to C with LEW)

Sample stage with measureable area of 200 mm x 160 mm, maximum sample height 120 mm, maximum sample weight 7 kg, and sample stage speed up to 100 mm/s, minimum step size 4 μ m





The novel instrument M4 TORNADO^{PLUS}



State-of-the-Art Hardware and Firmware

Includes all novel M4 features

Quick exchange sample table

Aperture Management System (AMS) (increased depth of field)

Light Element Detector Window (detecting elements down to Carbon)

Helium purge system (vacuum performance at atmospheric pressure)

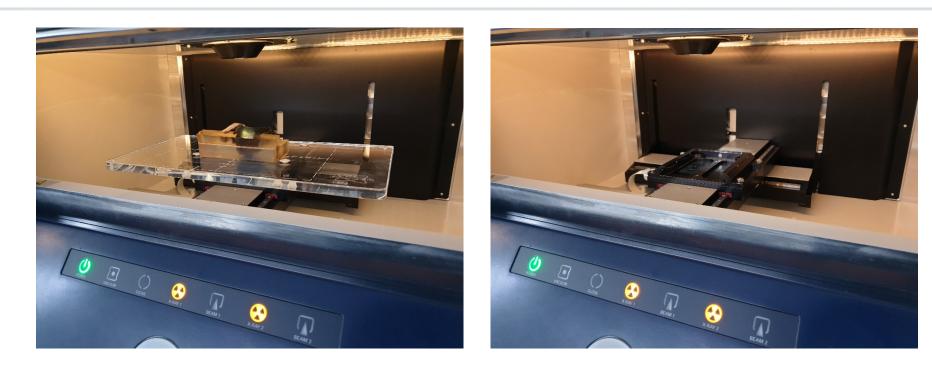
Collimator Changer for 2nd tube (adaption of spot size to the analytical task)

High Pulse throughput (processing of up to 550.000 counts per second)



Quick exchange sample stage

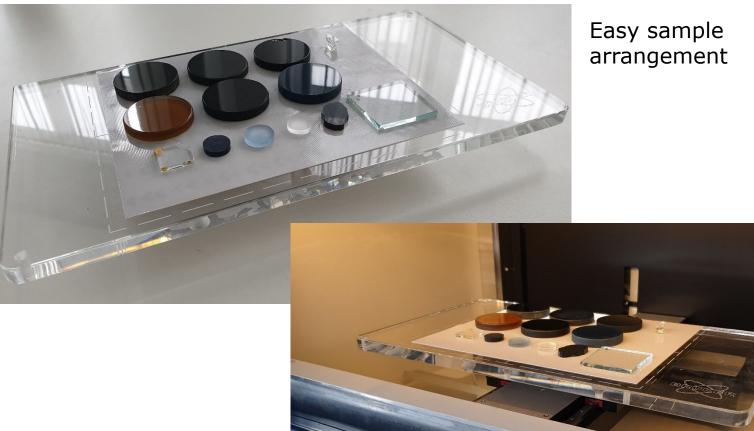




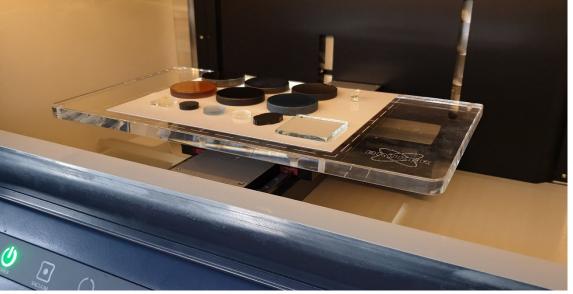
Easy-to-take-out dove tail sample stage can be fastened/unfastened in a second.

Quick exchange sample stage



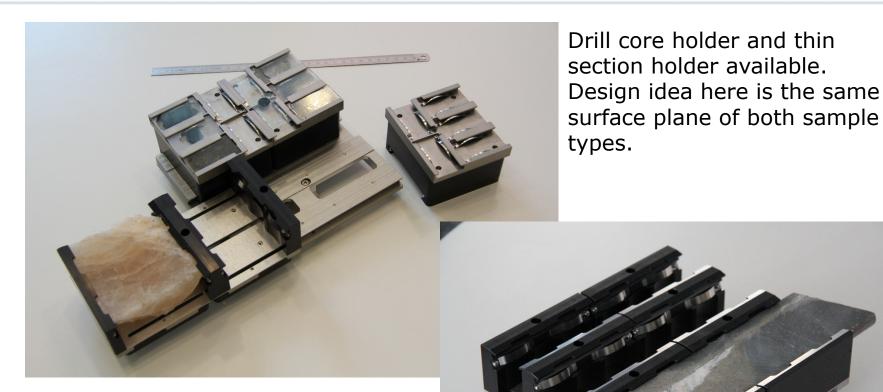


Quick sample stage mounting



Quick exchange sample stage Different options

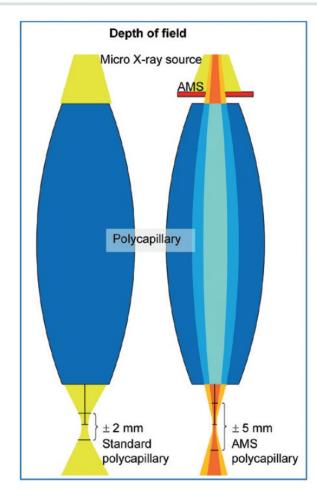


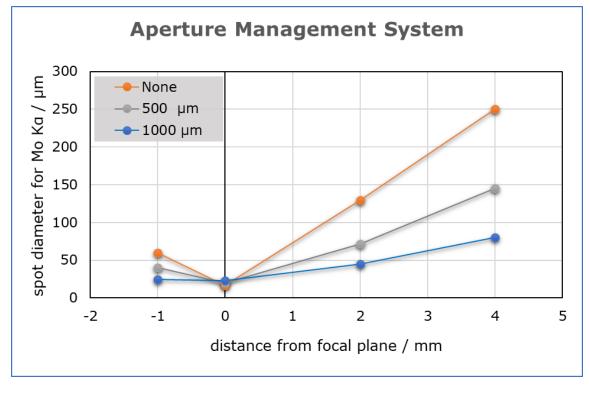


The standard acrylic glass stage is available as an accessory \rightarrow users can customize the stage for their specific samples.

Aperture Management System Introduction





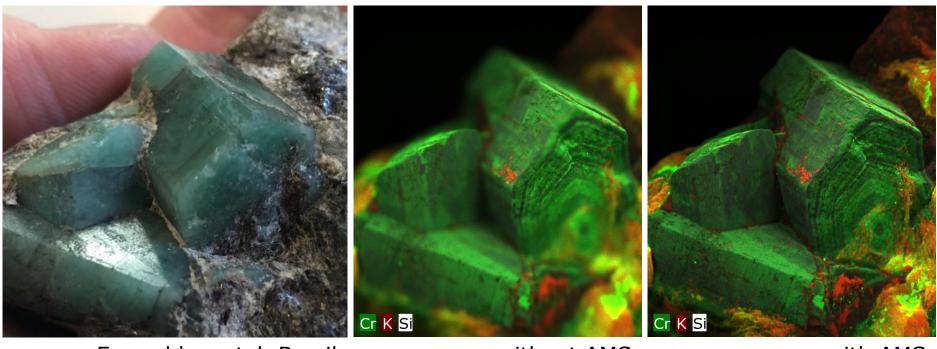


at 4 mm out of focal plane the spot size is reduced from $\sim 250~\mu m$ down to $\sim 75~\mu m$

Aperture management - patent pending

Aperture Management System High-topography samples





Emerald crystal, Brazil

without AMS

with AMS

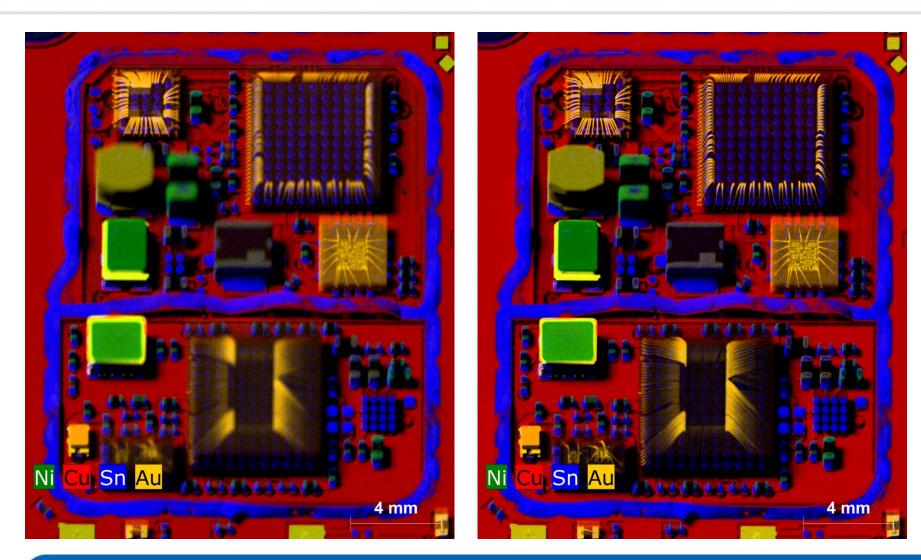
Aperture Management System High-topography samples





Aperture Management System High-topography samples





Light element detector windows Sensitivity

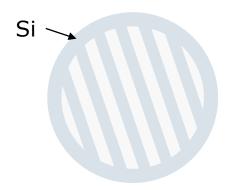


Conventional window:

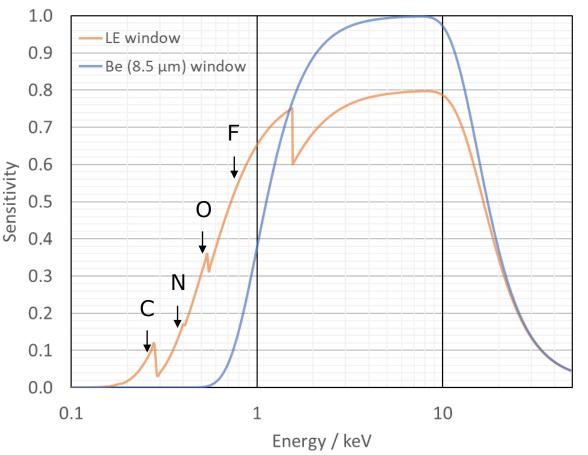
Be window with thickness between 8.5 µm and 12 µm

Light element window:

Thin polymer foil supported by a Silicon grid



Detector Sensitivity for different Window Types

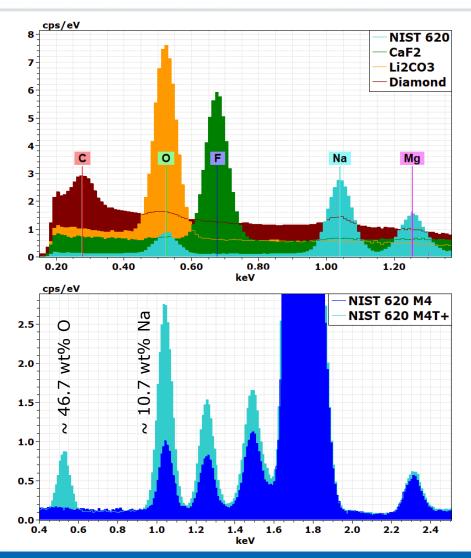


Light element detector windows Spectra



The ability to see the Carbon Ka fluorescence is to be considered a benchmark for the sensitivity of the instrument. The M4 TORNADO^{PLUS} is not well-suited for quantitatively analyzing Carbon! Especially not when scanning.

In this spectral region the sensitivity is low, line overlap and inter-element effects are very pronounced, information depth is too different from the other elements.



Light element detector windows Maps

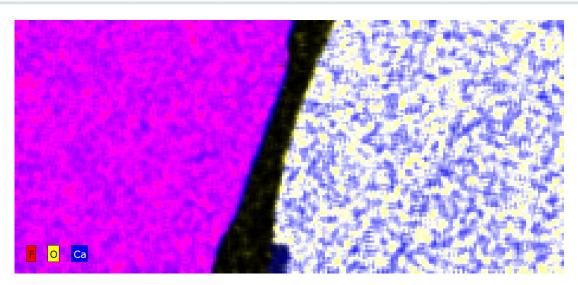


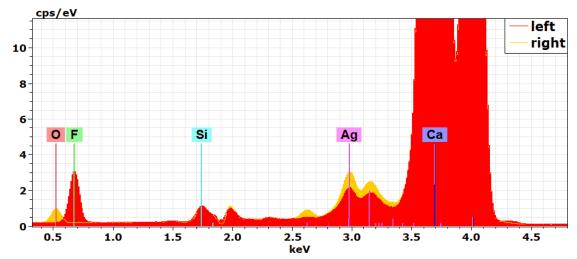
Calcite and Fluorite can hardly be discerned by usual micro-XRF (restricted to elements above and including Na).

The Fluorine signal is needed to discriminate the two minerals.

Example: CaF_2 on the left, CaCO₃ on the right side.







Helium purge system Why?



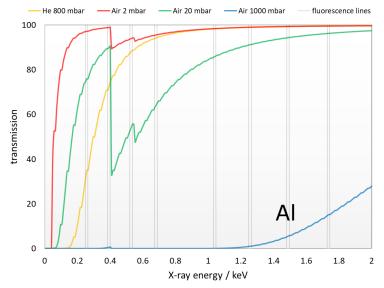
Analyzing light elements (< AI) is practically impossible at ambient pressure.

Evacuating the measurement chamber is a prerequisite. Standard measurement conditions are at 20 mbar (down to Na, M4 TORNADO) or 2 mbar (down to C, M4 TORNADO^{PLUS}).

BUT: Evacuation of the measurement chamber will lead to a quick evaporation of any water and other volatiles contained in a sample.

- \rightarrow not suitable for wet samples or hazardous materials
- \rightarrow Flow-controlled Helium purge as an option

Usual approach: carefully pump down to 800 mbar to seal the chamber and then exchange atmosphere with He (or other gases) → minimum He consumption for long-time measurement



He purge Prevent drying of wet samples





Fresh cut strawberry – a wet sample

Scan size: 31.2 mm x 30.5 mm

Step width: 20 µm

Map: 2.379.000 Pixel

Measurement time: 10 ms/Pixel

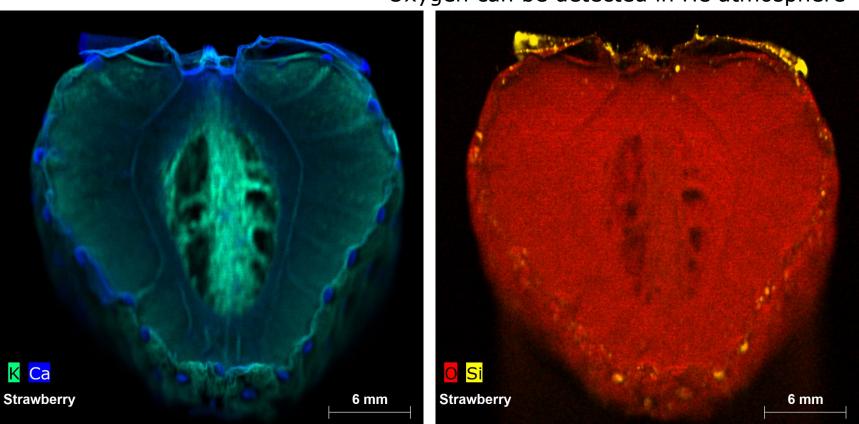
Overall time: 8:34 h

Tube: 50 kV / 600 mA

2x 60 mm² SDDs

He purge Prevent drying of wet samples

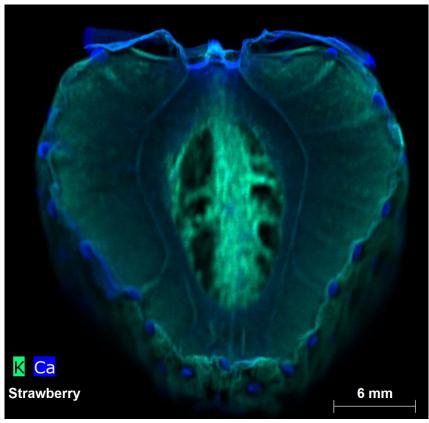




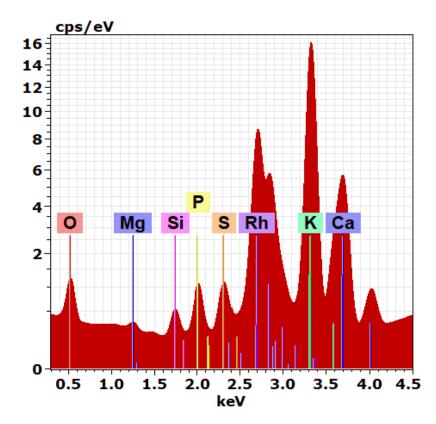
Oxygen can be detected in He atmosphere

He purge Prevent drying of wet samples



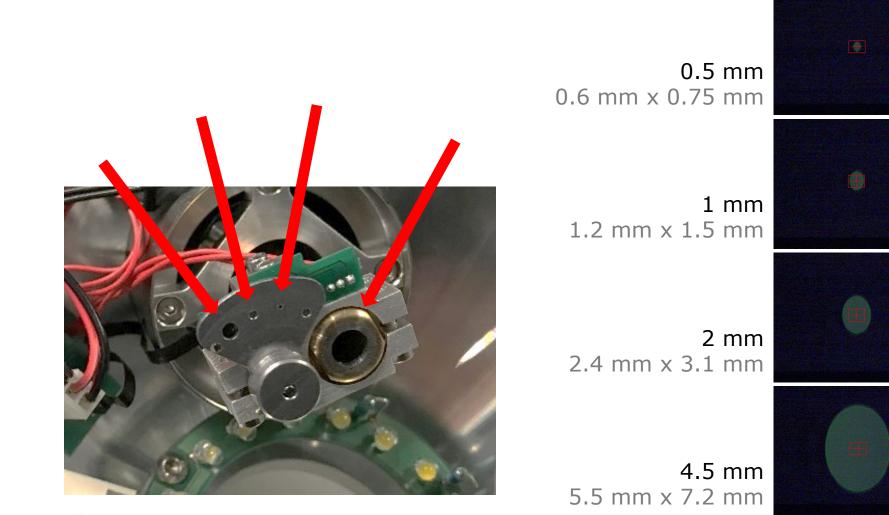


Oxygen can be detected in He atmosphere



Collimator Changer Introduction



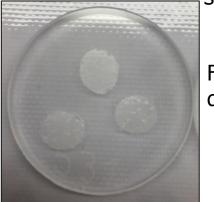


Application example Soaked-up liquids – Map approach



Idea:

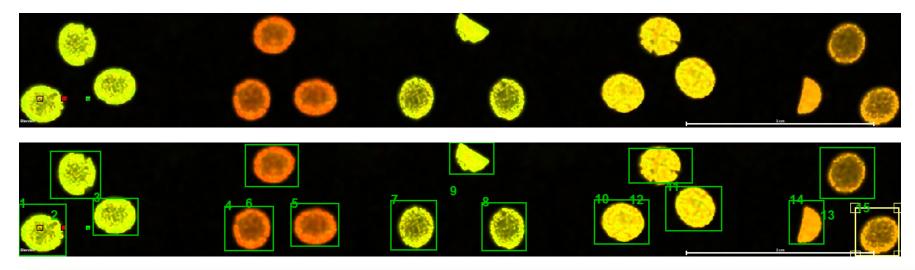
deposit a **defined amount of solution in a defined area**, — scan, and sum up the integral detected fluorescence intensity



For the analysis 5 μ l-droplets were deposited on a ~ Ø 6 mm absorbent tissue.

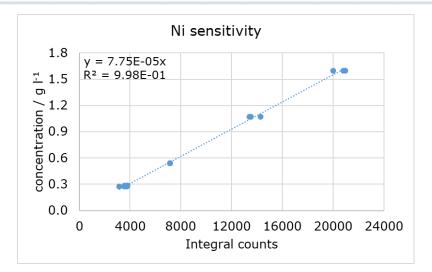
To evaluate effects of poor sample preparation, two samples were folded.

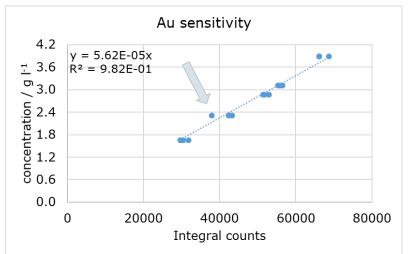


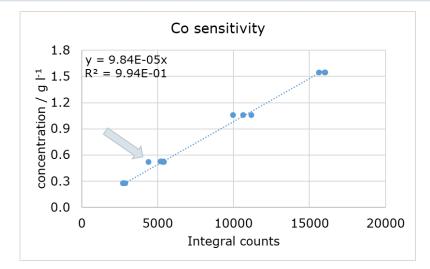


Application example Soaked-up liquids – Map approach









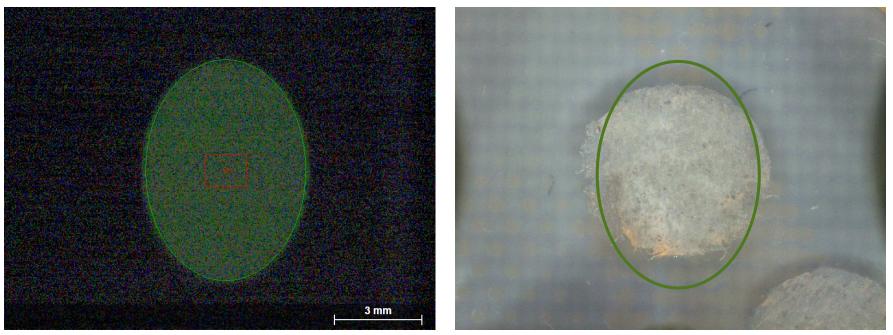
There is a very good linear correlation between the extracted intensity and the concentration. From the slope (sensitivity) the concentration in the sample can be derived. The main uncertainty results from the droplet preparation (see the deviation in the 3 dots for the same concentration).

The folded samples also results in small deviations (see arrow).

Application example Soaked-up liquids – with collimator



Alternatively: single spot measurement with very large collimator



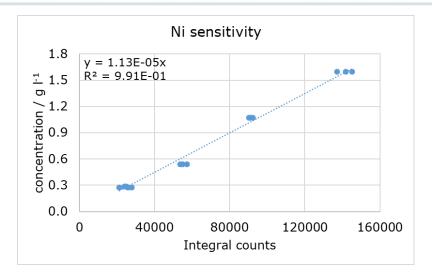
Using the 4.5 mm collimator the size of the X-ray beam on the sample is \sim 5.4 mm x 7.2 mm.

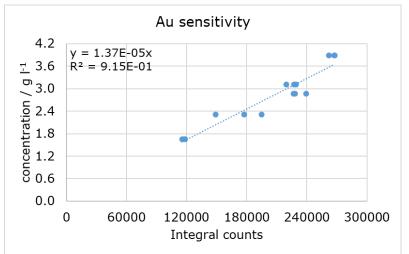
The spots overlaps reasonably well with the sample.

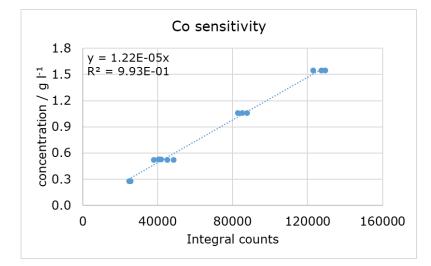
60 s realtime measurements per sample.

Application example Soaked-up liquids – with collimator









Again there is a good linear correlation between the extracted intensity and the concentration. The slope is different from the prior measurements, in line with different excitation conditions.

As some of the samples are not fully covered by the X-ray spot the correlation is not as good, especially since the elements are enriched at the edges of the tissue.

Application example Soaked-up liquids – comparison



Rh tube 20 μm lens spot and map

Spectrum	Co counts	Co [g/l]	Ni counts	Ni [g/l]	Au counts	Au [g/l]
S1	5099	0.50	6534	0.51	53746	3.02
S2	4996	0.49	6436	0.50	52392	2.95
S3	5147	0.51	6740	0.52	55375	3.11
S4	5980	0.59	7491	0.58	60326	3.39
average		0.52		0.53		3.12
S		0.04		0.03		0.17
s%		7.41		6.08		5.41
		0.52 ± 0.04		0.53 ± 0.03		3.12 ± 0.17

Rh tube 4.5 mm collimator spot and single spot

Spectrum	Co counts	Co [g/l]	Ni counts	Ni [g/l]	Au counts	Au [g/l]
S1	42249	0.52	46978	0.53	222252	3.03
S2	42240	0.52	46556	0.52	220602	3.01
S3	50818	0.62	56899	0.64	268763	3.67
S4	43497	0.53	48651	0.55	229864	3.14
average		0.55		0.56		3.21
s		0.04		0.05		0.27
s%		7.98		8.42		8.32
		0.52 ± 0.04		0.56 ± 0.05		3.21 ± 0.27

Collimator Changer Linearity of spectra

Smaller samples call for higher spatial resolution

30

25

20

15

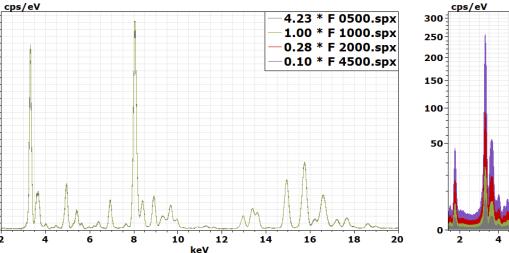
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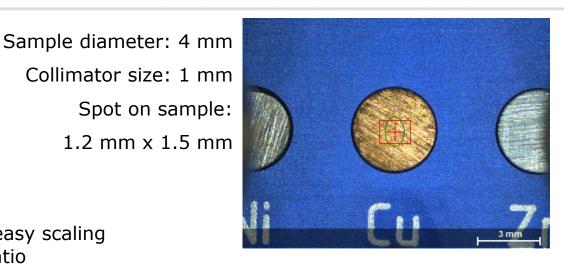
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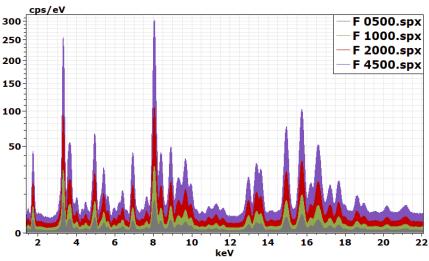
0

(possible secondary effects should be taken into account)

Spectra differ only in intensity \rightarrow easy scaling Intensity factor equals spot size ratio









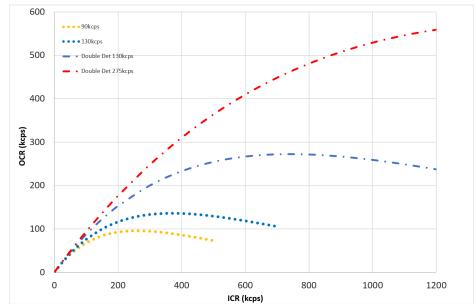
High pulse throughput Signal processing



Using 2x 60 mm² SDDs the solid angle of detection is huge and, hence, lots of photons hit the detector

Independent signal processing is an advantage, as each detector has to dal with "only" halt the count rate.

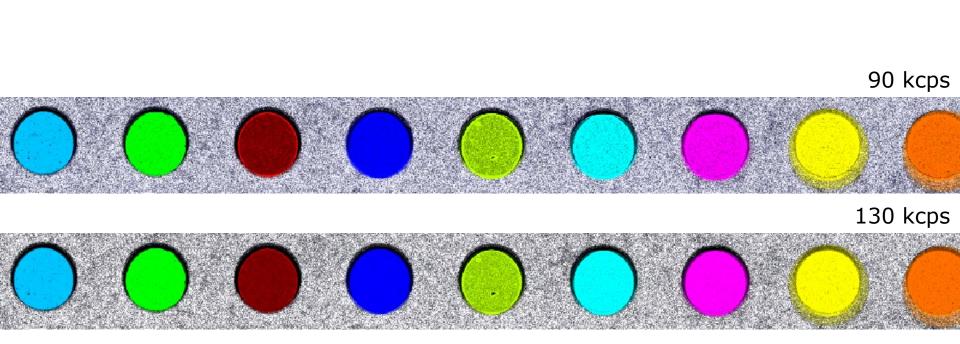
State-of-the-Art detector technology the use of signal processing units that allow to create 275.000 cps as maximum output count rate.



With the dual detector system 550 kcps out put count rate can be generated (at ~ 1.6 Mcps input count rate) while the energy resolution for Mn-Ka is still < 145 eV.

High pulse throughput Live part









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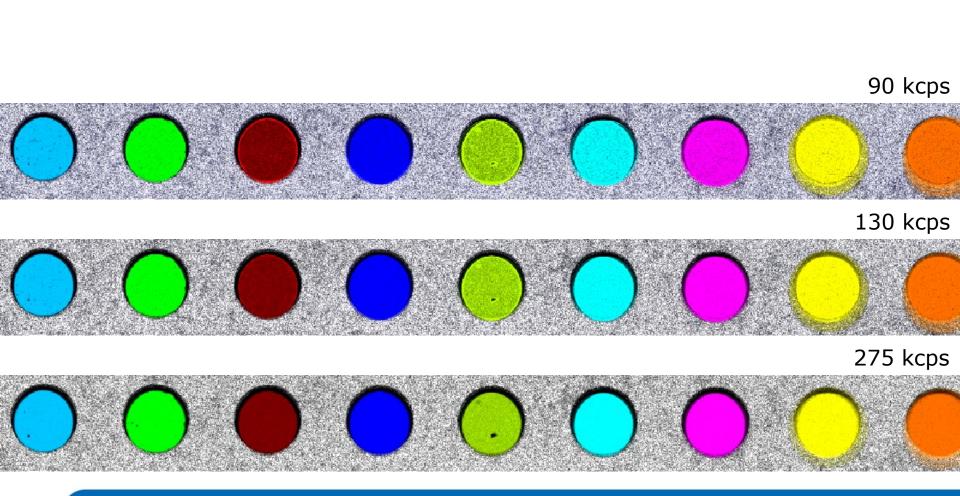
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High pulse throughput Live part

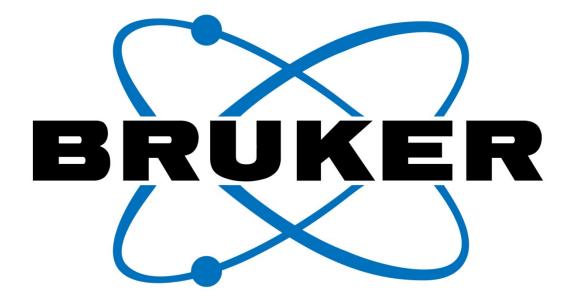








- The M4 TORNADO^{PLUS} represents the State of the Art of Bruker's micro-XRF instrumentation
- Several new features, like quick exchange stage, 9-filter-wheel, and high-throughput capability, became standard for the M4 TORNADO, as well
- X-ray tube and detection system of the M4 TORNADO^{PLUS} are optimized for light element detection
- The lightest detectable element is Carbon, whereas from Oxygen on quantification is feasible
- The collimator changer vastly increases the flexibility of the 2nd X-ray tube
- Flow-controlled Helium purge allows for long-term measurements with minimum sample drying and drastically reduced He consumption
- The Aperture Management System (AMS) increases the depth of field and, thus, allows for better qualitative analysis of uneven surfaces



Innovation with Integrity





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